

Overall Statistical Feature [USA, Semiconductor]

*****situation: beat_up*****

number of beat_up is: 61

Surprise

count 61.000000
mean 0.139069
std 0.144152
min 0.050300
25% 0.065500
50% 0.104300
75% 0.150000
max 0.907000

*****situation: beat_down*****

number of beat_down is: 59

Surprise

count 59.000000
mean 0.129258
std 0.096229
min 0.051400
25% 0.068250
50% 0.100000
75% 0.158750
max 0.543300

*****situation: miss_up*****

number of miss_up is: 4

Surprise

count 4.000000
mean 4.370900
std 7.433050
min 0.011000
25% 0.011975
50% 1.022000
75% 5.380925
max 15.428600

*****situation: miss_down*****

number of miss_down is: 8

Surprise

count 8.000000
mean 0.502962
std 0.707129
min 0.016900
25% 0.021575
50% 0.256700
75% 0.630200
max 2.076900

*****situation: fluctuate*****

number of fluctuate is: 19

Surprise

count 19.00000
mean 0.16620
std 0.15612
min 0.02410
25% 0.08480
50% 0.13310